

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/518,580	CHRISTENSEN ET AL.	NSEN ET AL.	
Examiner	Art Unit		
Brian D. Nguyen	2661		

SEARCHED					
Class	Subclass	Date	Examiner		
370	422	1/18/06	BN		
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	422 401 463 396 503				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East	1/12/06	BN		
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